

| Search Notes | Application/Control No. | Applicant(s)/Patent under Reexamination |
|--|-------------------------|---|
|  | 10/711,959 | HENG ET AL. |
| | Examiner | Art Unit |
| | Phallaka Kik | 2825 |

| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | |
|--|------------|------|
| | DATE | EXMR |
| BRS (EAST) --USPAT, USPGPUB New search Class/sub searched: 716/1-18 (see attached) | 12/26/2006 | PK |
| --EPO, JPO, IBM TDB, Derwent new search (see attached) | 12/26/2006 | PK |
| IEEE/IEEE Xplore new search (see attached) | 12/26/2006 | PK |
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